Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/684,188	FUJII ET AL.	
Examiner	Art Unit	
Drew J. Brown	3616	

	SEARCHED				
Class	Subclass	Date	Examiner		
280	728.3	8/18/2005	DB		
280	732	8/18/2005	DB		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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(INCLUDING SEAR	NOTES CH STRATEGY)
	DATE	EXMR
David Dunn	8/18/2005	DB
See Attachment	8/18/2005	DB
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